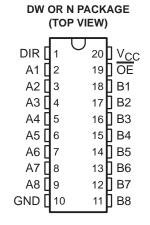
- Bidirectional Bus Transceivers in High-Density 20-Pin Packages
- Lower-Power Versions of SN74ALS640B and SN74ALS645A
- Package Options Include Plastic Small-Outline (DW) Packages and Standard Plastic (N) 300-mil DIPs

### description

These octal bus transceivers are designed for asynchronous two-way communication between data buses. These devices transmit data from the A bus to the B bus or from the B bus to the A bus, depending on the level at the direction-control



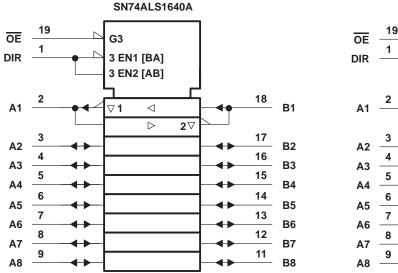
(DIR) input. The output-enable ( $\overline{\text{OE}}$ ) input can be used to disable the device so that the buses are effectively isolated. The SN74ALS1640A features inverting logic, while the SN74ALS1645A features noninverting logic.

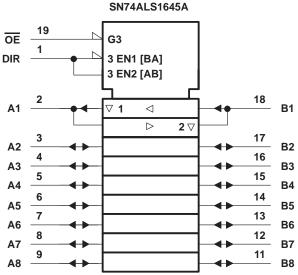
The SN74ALS1640A and SN74ALS1645A are characterized for operation from 0°C to 70°C.

#### **FUNCTION TABLE**

INPUTS		OPERATION			
ŌĒ	DIR	SN74ALS1640A	SN74ALS1645A		
L	L	B data to A bus	B data to A bus		
L	Н	A data to B bus	A data to B bus		
Н	X	Isolation	Isolation		

# logic symbols†





<sup>†</sup> These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

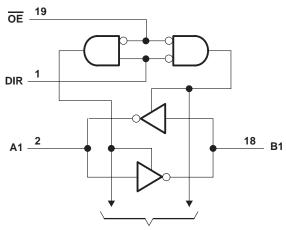


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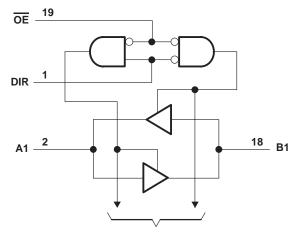
### logic diagrams (positive logic)

#### SN74ALS1640A





#### **SN74ALS1645A**



To Seven Other Transceivers

## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V <sub>CC</sub>	7 V
Input voltage, V <sub>I</sub> : All inputs	7 V
I/O ports	5.5 V
Package thermal impedance, $\theta_{JA}$ (see Note 1): DW package	97°C/W
N package	67°C/W
Storage temperature range, T <sub>Stq</sub>	. −65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

## recommended operating conditions

		SN74ALS1640A SN74ALS1645A		UNIT	
		MIN	NOM	MAX	
Vcc	Supply voltage	4.5	5	5.5	V
VIH	High-level input voltage	2			V
VIL	Low-level input voltage			0.8	V
ІОН	High-level output current			-15	mA
l <sub>OL</sub>	Low-level output current			16	mA
TA	Operating free-air temperature	0		70	°C



NOTE 1: The package thermal impedance is calculated in accordance with EIA/JEDEC Std JESD51, except for through-hole packages, which use a trace length of zero.

### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST	TEST CONDITIONS		SN74ALS1640A SN74ALS1645A		
					TYP <sup>†</sup>	MAX	
VIK		V <sub>CC</sub> = 4.5 V,	I <sub>I</sub> = -18 mA			-1.5	V
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -0.4 \text{ mA}$	V <sub>CC</sub> -2			
Voн		V== - 4.5.V	$I_{OH} = -3 \text{ mA}$	2.4	3.2		٧
		V <sub>CC</sub> = 4.5 V	$I_{OH} = -15 \text{ mA}$	2			
\/a.		V== 45V	I <sub>OL</sub> = 8 mA		0.25	0.4	· V
VOL		V <sub>CC</sub> = 4.5 V	I <sub>OL</sub> = 16 mA		0.35	0.5	
1.	Control inputs	V <sub>CC</sub> = 5.5 V	V <sub>I</sub> = 7 V			0.1	mA
lj .	A or B ports		V <sub>I</sub> = 5.5 V			0.1	mA
Luci	Control inputs	V <sub>CC</sub> = 5.5 V,	V. 27V			20	
ΊΗ	A or B ports <sup>‡</sup>		V <sub>I</sub> = 2.7 V			20	μΑ
IIL	Control inputs	V 55V	V <sub>1</sub> 0.4.V			-0.1	A
	A or B ports <sup>‡</sup>	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 0.4 V			-0.1	mA
IO§		V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 2.25 V	-30		-112	mA
Icc	SN74ALS1640A	V <sub>CC</sub> = 5.5 V			18	32	A
	SN74ALS1645A	V <sub>CC</sub> = 5.5 V			25	38	mA

## switching characteristics (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{CC}$ = 4.5 V to 5.5 V, $C_L$ = 50 pF, R1 = 500 $\Omega$ , R2 = 500 $\Omega$ , $T_A$ = MIN to MAX $\P$				UNIT
			SN74ALS1640A		SN74ALS1645A		
			MIN	MAX	MIN	MAX	
t <sub>PLH</sub>	A or B	B or A	4	15	2	13	ns
<sup>t</sup> PHL		D OF A	2	10	2	13	113
<sup>t</sup> PZH	ŌĒ	A a. D	5	20	8	25	ns
t <sub>PZL</sub>		A or B	5	22	8	25	115
<sup>t</sup> PHZ	ŌĒ	A or B	2	10	2	12	ns
<sup>†</sup> PLZ		AUID	5	13	3	18	113

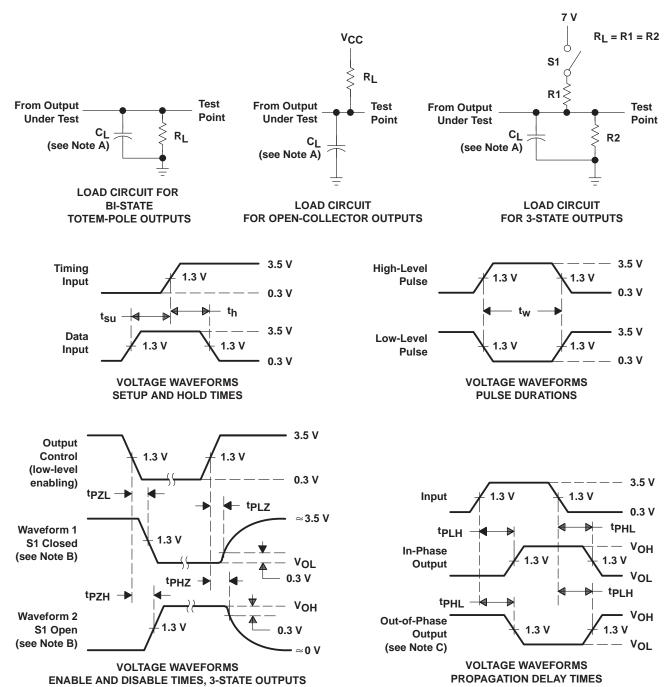
<sup>¶</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.



<sup>†</sup> All typical values are at  $V_{CC}$  = 5 V,  $T_A$  = 25°C. ‡ For I/O ports, the parameters  $I_{IH}$  and  $I_{IL}$  include the off-state output current.

<sup>§</sup> The output conditions have been chosen to produce a current that closely approximates one-half of the true short-circuit output current, IOS.

### PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



- NOTES: A. C<sub>L</sub> includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
  - C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
  - D. All input pulses have the following characteristics:  $PRR \le 1$  MHz,  $t_f = t_f = 2$  ns, duty cycle = 50%.
  - E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms



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